Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/026,429	OKAJIMA, AIKO
Examiner	Art Unit
CHAN S. PARK	2822-2615

SEARCHED					
Class	Subclass	Date	Examiner		
399	81-83	9/8/2005	CP CP		
358	1.15,1.12	9/8/2005	CP		
358	498	9/8/2005	CP		
-					

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
	1				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East (see the search history)	9/8/2005	P	
Mark Wallerson	2/24/06	СР	